Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/008,831	ARELLANO-PAYNE ET AL.
Examiner	Art Unit
CHAMELI C. DAS	2192

	SEARCHED					
Class	Subclass	Date	Examiner			
717	116,118	1/17/06	CP			
717	175-177 100,168 21,203					
709	201, 203					
709	205, U8 231					
709	223	*				
717	137,136					
709	246					

INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			
717	137 103	1/17/06	CD			
717	118					
709	201,205	1	1			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Checker double patenting WEST - us Pat-file - us PS perb - us US UCK	1/17/06	CO		
- JPO Abs - E FO Abs - DWP I - ZBM Tech				
Aem IEEE				